

Notice of References Cited	Application/Control No. 10/538,501		Applicant(s)/Patent Under Reexamination OMURA ET AL.	
	Examiner John P. Sheehan		Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,140,417 B2	11-2006	Schoen et al.	164/476
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*	D	US-2004/0016530 A1	01-2004	Schoen et al.	164/476
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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